Power MOSFET

-20 V, -8.3 A, Single P-Channel, Micro8 Leadless Package

Features

- Low R_{DS}(on) for Extended Battery Life
- Surface Mount Micro8 Leadless for Improved Thermal Performance
- Low Profile (<1.0 mm) Optimal for Portable Designs
- Low Turn-On Voltage
- This is a Pb-Free Device

Applications

- Optimized for Load Management Applications
- Charge Control in Battery Powered Systems
- Cell Phones, DSC, Notebooks, Portable Games, etc.

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Parameter			Symbol	Value	Unit	
Drain-to-Source Voltage			V_{DSS}	-20	V	
Gate-to-Source Voltage			V _{GS}	±8.0	V	
Continuous Drain	Steady State	T _A = 25°C	I _D	-8.3	Α	
Current (Note 1)		T _A = 85°C		-6.0		
	t ≤ 10 s	T _A = 25°C		-12		
Power Dissipation	Steady State T _A = 25°C		P _D	1.6	W	
(Note 1)	t ≤ 10 s			3.3		
Continuous Drain	Steady State	T _A = 25°C	I _D	-5.9	Α	
Current (Note 2)		T _A = 85°C		-3.7		
Power Dissipation (Note 2)	T _A = 25°C		P _D	0.8	W	
Pulsed Drain Current (Note 1)	t _p = 10 μs		I _{DM}	-25	Α	
Operating Junction and Storage Temperature		T _J , T _{STG}	-55 to 150	°C		
Source Current (Body Diode)			I _S	-1.6	Α	
Lead Temperature for Soldering Purposes (1/8 in from case for 10 s)		TL	260	°C		

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	80	°C/W
Junction-to-Ambient – $t \le 10 \text{ s (Note 1)}$	$R_{\theta JA}$	38	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta,JA}$	160	°C/W

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- Surface-mounted on FR4 board using 1 sq. in. pad size (Cu. area = 1.127 sq. in. [1 oz] including traces).
- Surface-mounted on FR4 board using minimum recommended pad size (Cu. area = TBD sq. in.).

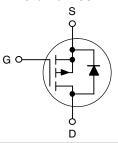


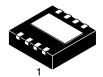
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V _{(BR)DSS}	R _{DS(on)} TYP	I _D MAX
-20 V	12.2 mΩ @ -4.5 V	-8.3 A
-20 V	15.6 mΩ @ -2.5 V	-0.3 A
	26.2 mΩ @ -1.8 V	

P-Channel MOSFET





Micro8 Leadless CASE 846C

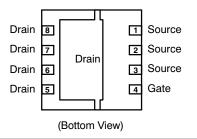
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MARKING DIAGRAM

> 3107 AYWW

A = Assembly Location
Y = Year
WW = Work Week
= Pb-Free Package

PIN ASSIGNMENT



ORDERING INFORMATION

Device	Package	Shipping [†]
NTLTS3107PR2G	Micro8 (Pb-Free)	2500/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$		-20			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V(BR)DSS/TJ				11		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = -16 V	T _J = 25°C			-10	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} =	± 8.0 V			±100	nA
ON CHARACTERISTICS (Note 3)					-		
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = -250 \mu A$		-0.45		-1.2	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				3.4		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = -4.5 V, I _D = -8.0 A			12.2	16	mΩ
		$V_{GS} = -2.5 \text{ V}, I_D$	= -7.0 A		15.6	21	1
		$V_{GS} = -1.8 \text{ V}, I_D = -5.8 \text{ A}$			26.2		1
Forward Transconductance	9FS	$V_{DS} = -5 \text{ V}, I_D = -8.0 \text{ A}$			25		S
CHARGES AND CAPACITANCES					•		
Input Capacitance	C _{ISS}	$V_{GS} = 0 \text{ V, f} = 1 \text{ MHz,}$ $V_{DS} = -16 \text{ V}$			5900	6500	pF
Output Capacitance	C _{OSS}				625	675	1
Reverse Transfer Capacitance	C _{RSS}				425	525	1
Total Gate Charge	Q _{G(TOT)}				55	70	nC
Threshold Gate Charge	Q _{G(TH)}	$V_{GS} = -4.5 \text{ V}, V_{DS} = -16 \text{ V},$ $I_{D} = -8.0 \text{ A}$			3.0		1
Gate-to-Source Gate Charge	Q _{GS}				7.0		1
Gate-to-Drain "Miller" Charge	Q _{GD}				11		1
SWITCHING CHARACTERISTICS (Note 4)						•	•
Turn-On Delay Time	t _{d(on)}	$V_{GS} = -4.5 \text{ V}, V_{DS} = -10 \text{ V},$ $I_{D} = -8.0 \text{ A}, R_{G} = 3.0 \Omega$			30		ns
Rise Time	t _r				20		
Turn-Off Delay Time	t _{d(off)}				250		
Fall Time	t _f				80		
DRAIN-SOURCE DIODE CHARACTERISTIC	S (Note 3)				-		
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 \text{ V},$ $I_S = -1.6 \text{ A}$	T _J = 25°C		-0.7	-1.2	٧
			T _J = 125°C		0.5		
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, } dI_{S}/dt = 100 \text{ A/}\mu\text{s,}$ $I_{S} = -1.6 \text{ A}$			75	100	ns
Charge Time	ta				28		1
Discharge Time	t _b				47		1
Reverse Recovery Charge	Q _{RR}				81.5		nC

Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

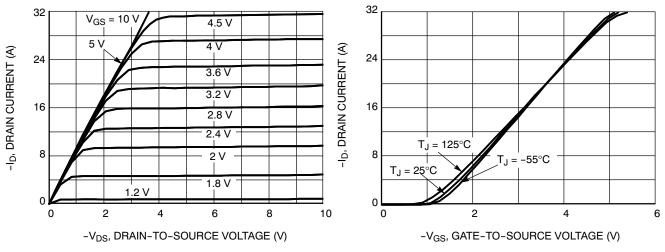


Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics

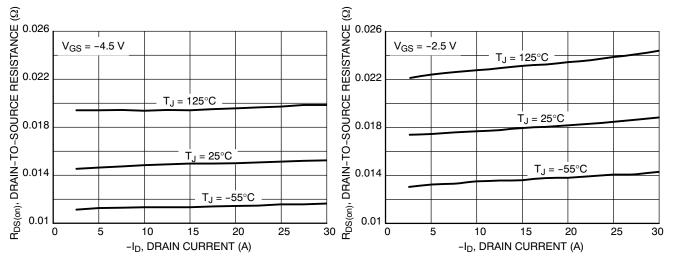


Figure 3. On-Resistance versus Drain Current and Temperature

Figure 4. On-Resistance versus Drain Current and Temperature

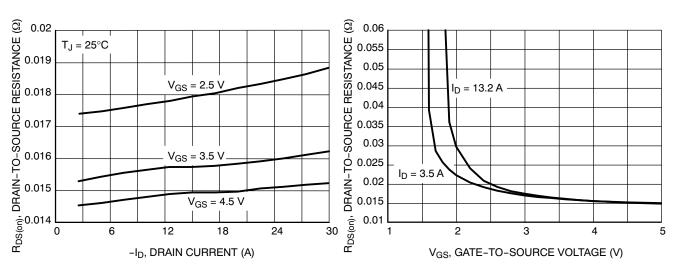


Figure 5. On-Resistance versus Drain Current and Gate Voltage

Figure 6. On-Resistance versus Gate Voltage

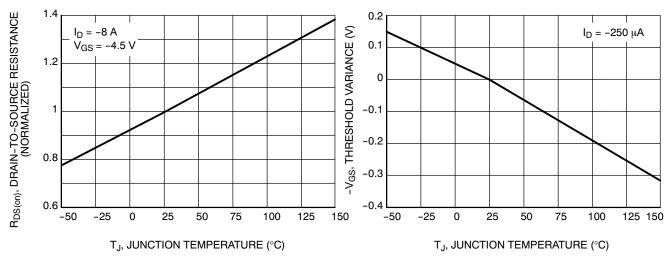


Figure 7. On-Resistance Variation with Temperature

Figure 8. Threshold Voltage

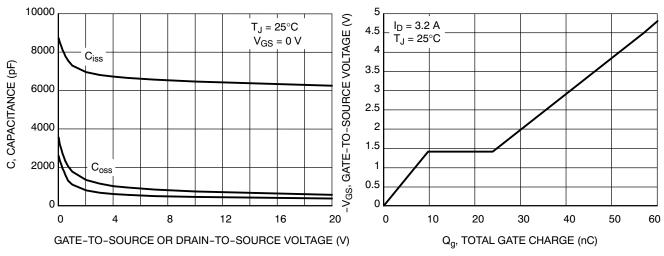


Figure 9. Capacitance Variation

Figure 10. Gate-to-Source and Drain-to-Source Voltage versus Total Charge

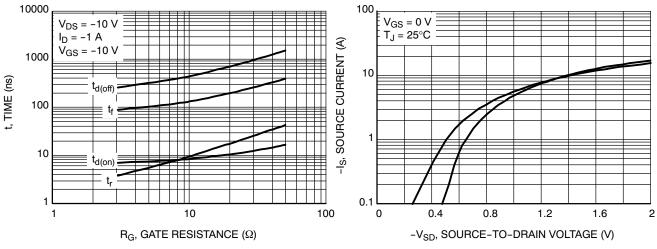


Figure 11. Resistive Switching Time Variation versus Gate Resistance

Figure 12. Diode Forward Voltage versus

Current

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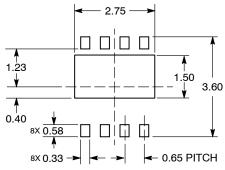
DETAIL Z

U 4X

DFN8 3x3, (MICRO8 LEADLESS) CASE 846C-01 ISSUE D T SEATING PLANE SCALE 4:1 ΔΔ INDEX AREA вГ R NOTF 6 6 F 5 0.15 2X AA **TOP VIEW** 0.15 Т 0.10 T 8X □ 0.08 T NOTE 4 0.10 TWY Ф W SIDE VIEW 0.05 Τ| L 8X D₈x 8 1 L1 NOTE 4 **G** 6X 6 3 5 4

SOLDERING FOOTPRINT*

VIEW AA-AA



DIMENSIONS: MILLIMETERS

*For additional information on our Pb-Free strategy and soldering details, please download the onsemi Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

- NOTES:
 1. DIMENSIONS AND TOLERANCING PER ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETER.
- THE TERMINAL #1 IDENTIFIER AND TERMINAL NUMBERING CONVENTION SHALL CONFORM TO JESD 95-1 SPP-012. DETAILS OF TERMINAL #1 IDENTIFIER ARE OPTIONAL, BUT MUST BE LOCATED WITHIN THE ZONE INDICATED. THE TERMINAL #1 IDENTIFIER MAY BE EITHER A MOLD OR MARKED FEATURE.
- DIMENSION D APPLIES TO METALLIZED
 TERMINAL AND IS MEASURED BETWEEN 0.25 MM AND 0.30 MM FROM TERMINAL TIP.
 DIMENSION L1 IS THE TERMINAL PULL BACK FROM PACKAGE EDGE, UP TO 0.1 MM IS ACCEPTABLE. L1 IS OPTIONAL.
- DEPOPULATION IS POSSIBLE IN A SYMMETRICAL FASHION.
- OPTIONAL SIDE VIEW CAN SHOW LEADS 5 AND 8 REMOVED.

	MILLIMETERS				
DIM	MIN MAX				
Α	3.30 BSC				
В	3.30	BSC			
С	0.85	0.95			
D	0.25	0.35			
E	1.30	1.50			
F	2.55	2.75			
G	0.65 BSC				
Н	0.95	1.15			
J	0.25	0.25 BSC			
K	0.00	0.05			
L	0.35	0.45			
L1	0.00	0.10			
P	1.28 1.38				
U	0 17 TYP				

GENERIC MARKING DIAGRAM*



XXXX = Specific Device Code = Assembly Location Α

= Year WW = Work Week = Pb-Free Package

(Note: Microdot may be in either location)

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present.

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DESCRIPTION:	DFN8 3X3, (MICRO8 LEADLESS)		PAGE 1 OF 1	

DETAIL Z

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